

-30V P-Channel Enhancement-Mode MOSFET

General Description

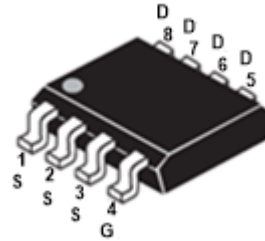
The AO4435 uses advanced trench MOSFET technology to provide excellent $R_{DS(on)}$, low gate charge and operation with gate voltages as low as -4.5V. This device is suitable for battery protection applications, used as a load switch or in PWM applications.

Features

- $V_{DS}=-30V$
- $I_D=-8.5A @V_{GS}=-10V$
- $R_{ds(on)}=19m\Omega(Typ.) @V_{GS}=-10V$
- $R_{ds(on)}=29m\Omega(Typ.) @V_{GS}=-4.5V$
- Advanced high cell density Trench technology
- High power and current handling capability
- Super Low Gate Charge
- Package: SOP-8
- Pb-Free and Green devices are available

Applications

- PWM Applications
- Power Management
- Load Switch
- Battery Switch



- | | |
|-----------|----------|
| 1. Source | 8. Drain |
| 2. Source | 7. Drain |
| 3. Source | 6. Drain |
| 4. Gate | 5. Drain |

Absolute Maximum Ratings ($T_A=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current ^a	I_D	$T_C=25^\circ C$	-8.5
		$T_C=70^\circ C$	-4.68
Drain Current –Pulsed ^a	I_{DM}	-30	A
Power Dissipation ($T_C=25^\circ C$)	P_D	3.0	W
Power Dissipation ($T_C=75^\circ C$)		2.0	
Storage Temperature Range	T_{STG}	-55 ~ +150	$^\circ C$
Operating Junction Temperature Range	T_J	-55 ~ +150	$^\circ C$
Thermal Resistance, Junction-to-Ambient1	$R_{\theta JA}$	60	$^\circ C/W$

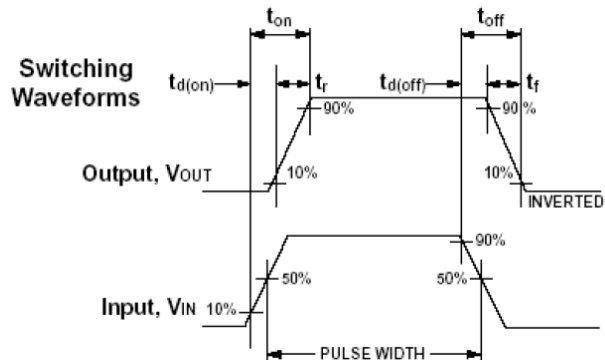
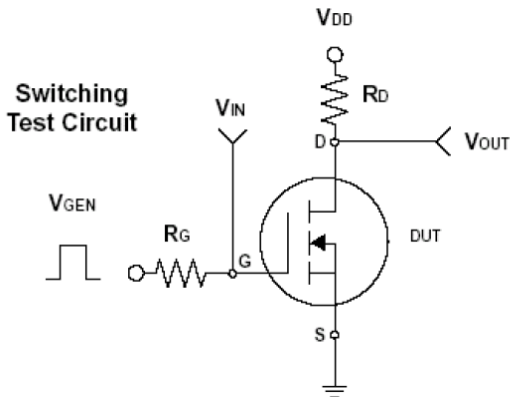
Electrical Characteristics ($T_A=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=-250\mu A$	-30	---	---	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=-24V, V_{GS}=0V$	---	---	-1	μA
Gate-Body Leakage			I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	---	---
On Characteristics ^a						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-1.0	---	-2.5	V
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS}=-10V, I_D=-8.0A$	---	19	26	m Ω
		$V_{GS}=-4.5V, I_D=-6.0A$	---	29	39	
Forward Transconductance	g_{fs}	$V_{DS}=-10V, I_D=-8A$	---	16	---	S

Drain-Source Diode Characteristics ^a						
Continuous Source Current	I_S	$V_G=V_D=0V$, Force Current	---	---	-8.5	A
Pulsed Source Current	I_{SM}		---	---	-17	A
Diode Forward Voltage	V_{SD}	$V_{GS}=0V$, $I_S=-8.0A$, $T_J=25^\circ C$	---	---	-1.2	V
Dynamic Characteristics ^b						
Input Capacitance	C_{iss}	$V_{DS}=-15V$, $V_{GS}=0V$, $F=1MHz$	---	930	---	pF
Output Capacitance	C_{oss}		---	148	---	
Reverse Transfer Capacitance	C_{rss}		---	115	---	
Switching Characteristics ^b						
Total Gate Charge	Q_g	$V_{DS}=-20V$, $V_{GS}=-4.5V$, $I_D=-8A$	---	9.8	---	nC
Gate-Source Charge	Q_{gs}		---	2.2	---	
Gate-Drain Charge	Q_{gd}		---	3.4	---	
Turn-On Delay Time	$T_{d(on)}$	$V_{DD}=-24V$, $V_{GS}=-10V$, $R_G=3.3\Omega$, $I_D=-1A$	---	16.4	---	ns
Rise Time	T_r		---	20.2	---	
Turn-Off Delay Time	$T_{d(off)}$		---	55	---	
Fall Time	T_f		---	10	---	

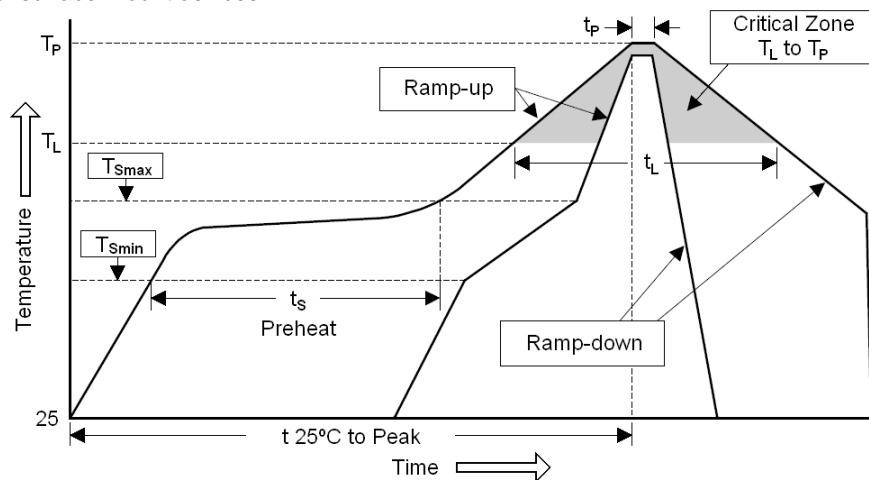
Notes: a. Repetitive Rating: Pulsed width limited by maximum junction temperature.
 b. Pulse test: pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
 c. Guaranteed by design, not subject to production testing.

Switching Time Test Circuit and Waveforms



Soldering Methods For Products

1. Storage environment : Temperature=10°C~35°C, Humidity=65%±15%
2. Reflow soldering of surface mount devices


Figure : Temperature Profile

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (T_L to T_P)	< 3°C/sec	< 3°C/sec
Preheat		
- Temperature Min (T_{Smin})	100°C	100°C
- Temperature Max (T_{Smax})	150°C	200°C
- Time (Min to Max) (t_s)	60 ~ 120 sec	60 ~ 180 sec
T_{Smax} to T_L		
- Ramp-up rate	< 3°C/sec	< 3°C/sec
Time maintained above:		
- Temperature (T_L)	183°C	217°C
- Time (t_L)	60 ~ 150 sec	60 ~ 150 sec
Peak Temperature (T_P)	240°C +0/-5°C	260°C +0/-5°C
Time within 5°C of actual Peak Temperature (t_p)	10 ~ 30 sec	20 ~ 40 sec
Ramp-down rate	< 6°C/sec	< 6°C/sec
Time 25°C to Peak Temperature	< 6 minutes	< 8 minutes

3. Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time
Pb devices	245°C ±5°C	5sec ±1sec
Pb-Free devices	260°C +0/-5°C	5sec ±1sec

- 经锡炉或回焊炉的温度切勿超过 260 °C (Max safe temperature: 260°C)。

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- MOS 管电路是静电敏感元器件，且对生产环境要求较严，建议在存放、运输及生产操作时一定要避免静电干扰。
- 由于每个 PCB 版图和设计都不同，每个 MOSFET 的结构也不同，因此，没有通用的流程可用来计算每个应用的最大允许电流，建议在选用 MOS 管器件时考虑到余量，以免 MOS 管因此而造成损坏。